

Description

The series of devices uses **Super Trench II** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{\text{DS(ON)}}$ and Q_g . This device is ideal for high-frequency switching and synchronous rectification.

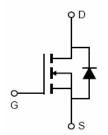
Application

- DC/DC Converter
- •Ideal for high-frequency switching and synchronous rectification

General Features

- V_{DS} =100V, I_D =230A $R_{DS(ON)}$ =2.15m Ω , typical@ V_{GS} =10V
- Excellent gate charge x R_{DS(on)} product(FOM)
- Very low on-resistance R_{DS(on)}
- 175 °C operating temperature
- Pb-free lead plating





Schematic Diagram

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VST10N021-T7	VST10N021	TO-247	-	-	-

Absolute Maximum Ratings (T_C=25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	100	V	
Gate-Source Voltage	V _G s	±20	V	
Drain Current-Continuous	I _D	230	А	
Drain Current-Continuous(T _C =100℃)	I _D (100℃)	165	А	
Pulsed Drain Current	I _{DM}	920	Α	
Maximum Power Dissipation	P _D		W	
Derating factor		2	W/℃	
Single pulse avalanche energy (Note 5)	E _{AS}	2300	mJ	
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 175	$^{\circ}$	

Thermal Characteristic

Thermal Resistance,Junction-to-Case ^(Note 2)	$R_{ heta JC}$	0.5	°C/W
---	----------------	-----	------



Electrical Characteristics (T_C=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics			•	•		•
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250µA	100		-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =100V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)			•	•		•
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.0	3.0	4.0	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =115A	-	2.15	2.6	mΩ
Forward Transconductance	g FS	V _{DS} =5V,I _D =115A		90	-	S
Dynamic Characteristics (Note4)			<u>.</u>			•
Input Capacitance	C _{lss}	V _{DS} =50V,V _{GS} =0V,	-	14000	-	PF
Output Capacitance	C _{oss}		-	1100	-	PF
Reverse Transfer Capacitance	C _{rss}	F=1.0MHz	-	60	-	PF
Switching Characteristics (Note 4)			<u>.</u>			•
Turn-on Delay Time	t _{d(on)}	V_{DD} =50V, I_{D} =115A V_{GS} =10V, R_{G} =1.6 Ω	-	34	-	nS
Turn-on Rise Time	t _r		-	27	-	nS
Turn-Off Delay Time	t _{d(off)}		-	78	-	nS
Turn-Off Fall Time	t _f		-	30	-	nS
Total Gate Charge	Qg	V _{DS} =50V,I _D =100A,	-	240	-	nC
Gate-Source Charge	Q _{gs}		-	62		nC
Gate-Drain Charge	Q _{gd}	V _{GS} =10V	-	73		nC
Drain-Source Diode Characteristics			<u>.</u>			
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =115A	-		1.2	V
Diode Forward Current (Note 2)			-	-	200	Α
Reverse Recovery Time	t _{rr}	$T_J = 25^{\circ}C, I_F = 115A$	-	101	-	nS
Reverse Recovery Charge	Qrr	$di/dt = 100A/\mu s^{(Note3)}$	-	280	-	nC

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production
- 5. EAS condition : Tj=25 $^{\circ}\!\!\mathrm{C}$,V_DD=50V,V_G=10V,L=0.5mH,Rg=25 Ω





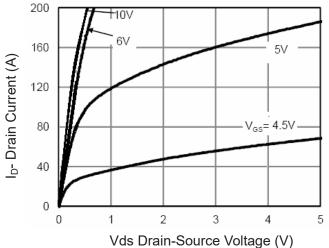


Figure 1 Output Characteristics

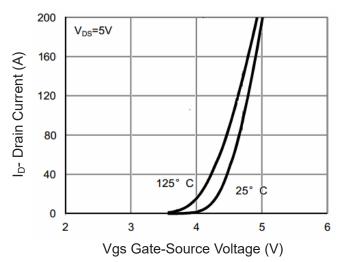


Figure 2 Transfer Characteristics

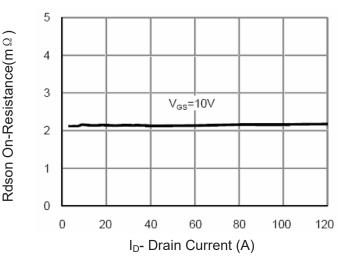


Figure 3 Rdson-Drain Current

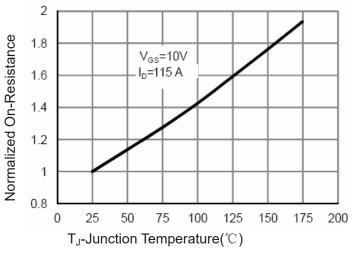


Figure 4 Rdson-Junction Temperature

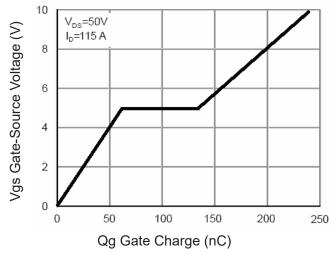


Figure 5 Gate Charge

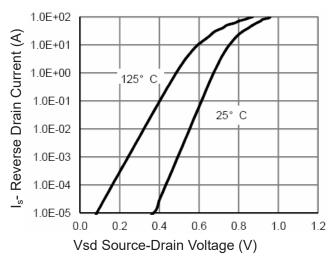


Figure 6 Source- Drain Diode Forward



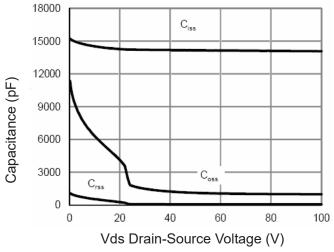


Figure 7 Capacitance vs Vds

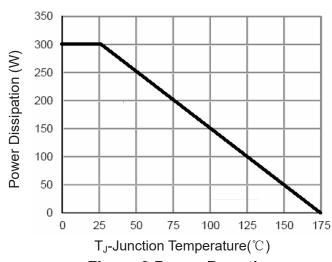


Figure 9 Power De-rating

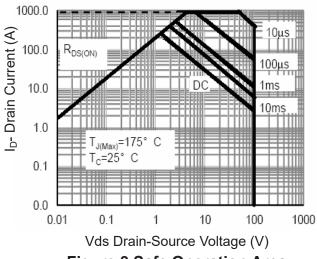


Figure 8 Safe Operation Area

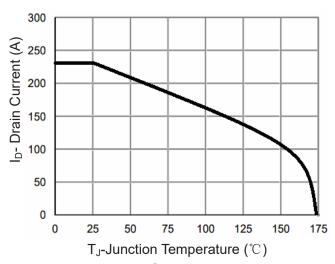


Figure 10 Current De-rating

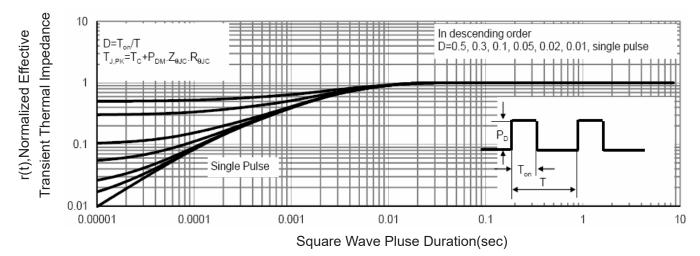


Figure 11 Normalized Maximum Transient Thermal Impedance